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LCR METER IM3523/IM3533/IM3533-01

Component measuring instruments

ΗΙΟΚΙ







From Production Lines to Research and Development A New Series of LCR Meters to Meet Your Applications

F

New LCR METER Models IM3523, IM3533, and IM3533-01 are highly cost-effective testers that provide greater performance and better functionality than previous HIOKI models, such as a high basic accuracy of $\pm 0.05\%$, a wide measurement frequency from 1 mHz (40 Hz for the IM3523) to 200 kHz, high-speed measurement of up to 2 ms, highly reliable measurement using the contact-check function, and measurement of turn ratio and mutual inductance. Select the best model according to your application, from production lines to research and development.





For Production Lines The Perfect Impedance Analyzer

Product Lineup





*1 The check and double-check marks in the "Usage" rows indicate the recommendation level. The double-check mark represents a highly recommended application.

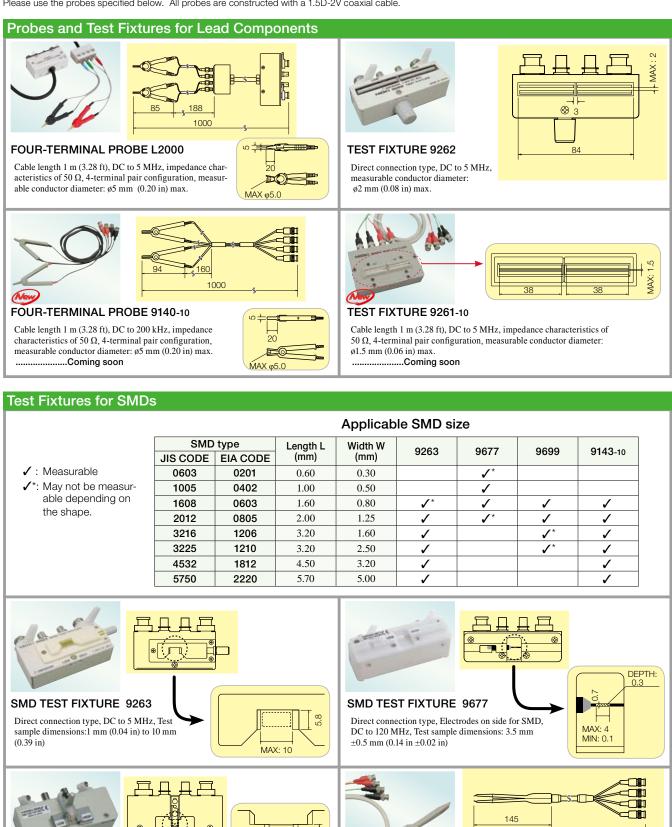
Model		LCR METER IM3523	LCR METER IM3533	LCR METER IM3533-01	
	Research and development	v	~	~ ~	
Usage ^{*1}	Transformer and coil production	v	V V	~ ~	
	LCR component production	~ ~	V V	~ ~	
Measurement items	Basic measurement items	$ \begin{array}{c} Z \ (impedance \ [\Omega]) \\ Y \ (admittance \ [\Omega]) \\ \theta \ (phase \ angle \ [^{o}]) \\ Rs \ (equivalent \ series \ resistance = ESR \ [\Omega]) \\ Rp \ (parallel \ resistance \ [\Omega]) \\ X \ (reluctance \ [\Omega]) \\ X \ (reluctance \ [\Omega]) \\ G \ (conductance \ [S]) \\ B \ (susceptance \ [S]) \\ B \ (susceptance \ [S]) \\ Ls \ (series \ inductance \ [H]) \\ Lp \ (parallel \ inductance \ [H]) \\ Lp \ (parallel \ inductance \ [H]) \\ Cs \ (series \ capacitance \ [F]) \\ Cp \ (parallel \ capacitance \ [F]) \\ Q \ (Q \ factor \ (Q = 1/D)) \\ D \ (loss \ coefficient = \ tan \delta) \end{array} $		SR [Ω])	
	DCR (direct current resistance)	\checkmark	\checkmark (with temperature compensation func		
Transformer measurement		_	N (turn radio) M (mutual inductance) ΔL (inductance difference)		
Temperature T		_	1		
E	Basic accuracy	±0.05%rdg.			
Meas	urement frequency	40Hz to 200kHz	1mHz to 200kHz		
Mea	surement voltage	5mV to 5V	5mV to 5V/ 2.5V* 2		
Me	easurement time	2ms	2ms		
Comparator BIN measurement Cable length		2 items: HI/IN/LO, ABS/%/Δ%			
		Main item: 10 categories Sub-item: 1 category			
		0m/1m	0m/1m	0m/1m/ 2m/4m	
Contact check		4-terminal contact check (threshold change) / Hi-Z		Hi-Z reject	
Internal [DC bias measurement	-	-5V	to 5V	
Sweep measurement		-	-	Frequency 2 to 801 points	
	Display	Monochrome LCD	Color TFT 5.7-incl	n LCD touch panel	
	EXT I/O, USB	\checkmark	v	/	
Interface	USB flash drive	_	✓		
RS-232C, GP-IB, LAN		Option (select one)			

Highlighted functions in **bold-type** in the IM3533 and IM3533-01 section are more advanced than those of the IM3523.

^{*2} 2.5 V in the low impedance high accuracy mode

For Lead Components and Surface Mounted Devices (SMDs) **Probes & Test Fixtures**

Please use the probes specified below. All probes are constructed with a 1.5D-2V coaxial cable.



0

PINCHER PROBE 9143-10

.....Coming soon

Cable length 1 m (3.28 ft), DC to 5 MHz, impedance

characteristics of 50 Ω , 4-terminal pair configuration

1150

SMD TEST FIXTURE 9699

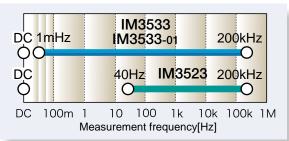
Direct connection type, Electrodes on bottom for SMD, DC to 120 MHz, Test sample dimensions: 1.0 mm (0.04 in) to 4.0 mm (0.16 in) wide, maximum 1.5 mm (0.06 in) high

Features High-Speed, High-Accuracy, and Easy-to-Use

Basic Performance

Wide measurement frequency range

The measurement frequency can be freely set to DC or any value in the 1 mHz (40 Hz for the IM3523) to 200 kHz range at high resolution (five-digit resolution [1 mHz resolution for less than 100 Hz]). This makes it possible to measure the resonant frequency and perform measurement and evaluation under conditions close to actual conditions.



Wide setting range for measurement voltage and current

In addition to normal open-loop signal generation, these models enable voltage/current dependent measurement in constant voltage/current modes.

The signal levels can be set over wide ranges from 5 mV to 5 V and from 10 μ A to 50 mA. (The setting range of measurement signal levels varies depending on the frequency and measurement mode.)

IM3523 IM3533 IM3533-01

Basic accuracy ±0.05%

The basic accuracy of Z is $\pm 0.05\%$. This fits a wide array of applications ranging from the inspection of parts to research and development measurements.

Accuracy guaranteed at measurement cables of up to 4 meters

Four-terminal pair configuration reduces the influence of measurement cables and accuracy is guaranteed at the measurement cable lengths of up to 4 meters. This simplifies the wiring of automated machinery. With models IM3523 and IM3533, accuracy is guaranteed at measurement cable lengths of up to 4 meters with the cable length correction set to 1 meter. (The frequency range for which accuracy is guaranteed varies depending on the cable length.)

• 15 parameters can be measured

The following parameters can be measured and selected parameters can be imported to a computer: Z, Y, θ , Rs (ESR), Rp, Rdc (DC resistance), X, G, B, Ls, Lp, Cs, Cp, D (tan δ), and Q.

Fastest measurement time 2 ms

The fastest measurement time of 2 ms at a measurement frequency of 1 kHz and the measurement speed FAST improves the inspection throughput used in automated machinery.

IM3523

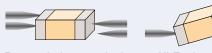
IM3533

IM3533-01

Functions and Features for LCR Measurements on Production Lines

Contact check function incorporated

The contact check function for four-terminal measurement and the Hi-Z reject function for two-terminal measurement ensure the measurement electrode is in contact with the measurement object during measurement.



Four-terminal contact check High contact resistance is determined to be an error. The

threshold of contact resistance

can be changed

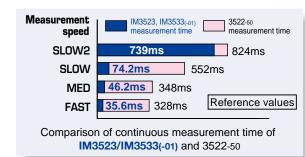


Significantly high impedance is determined to be a Hi-Z error.

Continuous measurement under different measurement conditions

Different measurement items can be measured continuously under different measurement conditions (frequency, level, and mode).

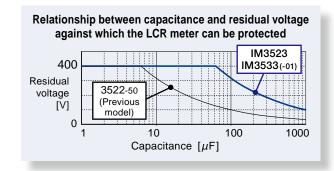
Advantage #1



Protection against charged capacitors*

To address situations when a charged capacitor is incorrectly connected to the measurement terminal, the protection function* has been improved to 10 times of the amount of residual charge of the previous model 3522-50.

* This function does not guarantee the measurement of charged capacitors. Be sure to discharge the capacitor before measuring it.



With continuous measurement under varying measurement conditions such as C-D + ESR measurement of capacitors, the total measurement time has been shortened significantly from the previous HIOKI model 3522-50. In addition to the reduction of the time required for individual measurements, the time required to change ranges such as a frequency range has been reduced significantly.

Features of LCR Meter Model IM3523 Integration into Production Lines and Automated Machinery



simple, easy-to-read monochrome LCD

IM3523

A simple user interface is provided with a high-contrast graphic LCD display, function keys, and numeric keypad. For numeric value settings such as the comparator setting, the numeric keypad can be used to enter numbers easily and quickly.



General specifications of the IM3523

	Basic measure- ment items	Z,Y, θ ,Rs,R	p,X,G,B,Ls,Lp,Cs,Cp,Q,D	
Measure-	DCR	✓		
ment items	Transformer measurement		-	
	Temperature T		-	
Basic	c accuracy		±0.05%rdg.	
Measurer	ment frequency	4	0Hz to 200kHz	
Measurement voltage		5mV to 5V		
Measurement time		2ms		
Comparator		2 item	s: HI/IN/LO, ABS/%/Δ%	
BIN measurement		10 main classi	fications/1 sub-classification	
Cab	Cable length		0m/1m	
Contact check		4-terminal contact check (threshold change) / Hi-Z reject		
Internal DC I	Internal DC bias measurement		_	
Sweep measurement		-		
Display		Monochrome LCD		
EXT I/O,		, USB	1	
Interface	USB flas	h drive	_	
	RS-232C, G	P-IB, LAN	Option (select one)	

Compact size ideal for integration into production lines and automated machinery

The size is the same as that of compact measuring instruments for bench use - smaller than the previous model - fitting easily into automated machinery and production processes.

Comparator

In LCR mode, the meter allows for Hi, IN, and Lo

judgments of two types from the measurement items. For the judgment method, % setting and Δ % setting are available in addition to absolute value setting. If continuous measurement is used, judgments which span over multiple measurement conditions and measurement items are possible.

BIN measurement

With the IM3523, the main item can be classified into 10 categories and out of range, and the sub-item into 1 category and out of range.



IM3533-01

IM3533-01

IM3523

IM3523

Functions and Features Suitable for Measurements and Inspection on Production Lines

Auto-range control function

When a measurement object crosses over multiple ranges, measurement can be tailored by controlling the moving-range of the auto-range. Measurement can be performed by taking advantage of both the wide measurement range of the auto-range and the reduction of the measurement time achieved by completing a search only in the specified range.

Individual items of two continuous measurements can be output from EXT I/O

IM3523

IM3533

For two types of continuous measurement judgment items, individual judgment results can be captured from EXT/IO. This makes it possible to perform more detailed inspections and sorting.

Functions and Features to Reduce the Time Needed to Prepare for Measurement

IM3533

Limit-linked range setting and range-linked setting function

The optimal range is automatically set according to the set reference value or range. In addition, the measurement conditions can be automatically set to be optimized according to the change in the range, reducing the preparation time.

OPEN/SHORT compensation area setting function

IM3523

When the measurement frequency range is limited, OPEN/SHORT compensation can be executed by limiting the compensation area to the actual frequency range being measured. The time required to execute OPEN/SHORT compensation is then significantly reduced compared to the time needed to compensate the entire range.

Features of LCR Meter Model IM3533 Winding, Coil and Transformer Production



Transformer measurement

IM3533 IM3533-01

Turn ratio N, mutual inductance M, and inductance difference ΔL can be measured on the transformer measurement screen.

DCR measurement with temperature compensation^{*2}



For DCR measurement of inductor and transformer windings, measurement can be performed while compensating for temperature. *² Temperature Probe 9478 (option) is required for DCR measurement with temperature compensation.

Simultaneously display 4 parameters (for normal measurement)



For normal measurement, four parameters can be displayed simultaneously. This makes it easy to check parameters by comparing them with each other.

• General specifications of the IM3533

	Basic measure- ment items	Z,Y, θ ,Rs,R	p,X,G,B,Ls,Lp,Cs,Cp,Q,D	
Measure-	DCR	✓ (with temper	rature compensation function)	
ment items	Transformer measurement		N,M,⊿L	
	Temperature T		1	
Basic	c accuracy		±0.05%rdg.	
Measurer	Measurement frequency		mHz to 200kHz	
Measurement voltage		5	5mV to 5V/2.5V ^{*1}	
Measurement time		2ms		
Comparator		2 item	s: HI/IN/LO, ABS/%/Δ%	
BIN measurement		2 item	ns: 10 classifications	
Cab	Cable length		0m/1m	
Cont	Contact check		4-terminal contact check (threshold change) / Hi-Z reject	
Internal DC I	Internal DC bias measurement		-5V to 5V	
Sweep measurement		-		
Display		Color TFT 5.7-inch LCD touch screen		
	EXT I/O	, USB	1	
Interface	USB flas	h drive	1	
	RS-232C, GP-IB, LAN		Option (select one)	
	*10.5 V is the law importance high a summer mode			

^{*1} 2.5 V in the low impedance high accuracy mode

Internal DC bias -5 V to 5 V

IM3533 IM3533-01

IM3533-01

IM3533-01

The instruments can perform measurements alone by applying a DC bias of up to ± 5 V. This is reassuring when measuring polar capacitors such as a tantalum capacitor.

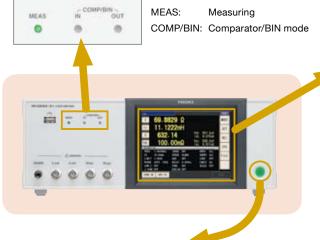
BIN measurement: Two items are classified into 10 categories

Two items can be classified into 10 categories and out of range. This function is useful for sorting out composite parts and performing advanced sorting.

Functions and Features to Simplify the Operation of LCR Measurements

Instrument mode indicators

Indicators allow you to identify the operating conditions of the instrument even when the touch screen is off.



Power indicator

The power indicator allows you to identify the on/off status of the LCR meter even when integrated into automated machinery or the LCD display is off.

Power on: green Standby: red

• Easy touch screen operation

A touch screen with intuitive operation is inherited from previous models. Furthermore, the incorporation of a color LCD means the display is easy to view, and outstanding, easy-to-understand operability helps improve work efficiency.



(LCR mode)



Setting items of basic measurement conditions

Easily change the measurement conditions such as the measurement frequency and measurement signal level while you monitor the measurement values.



IM3533



Frequency setting (numeric keypad input and up/down input)

Features of LCR Meter Model IM3533-01 Research and Development and Electrochemistry



• Frequency sweep

IM3533-01

Measurements can be performed automatically at up to 801 frequency points by specifying the frequency range or in the frequency list mode. The measurement results can be saved to a USB flash drive or to a computer via an interface, which then can be used to perform frequency analysis of samples.

REQ1Hr1	1(0)	40-1	
05.83	20. 4452k	-88, 680	
22.09	19.9123k	-88.673	-
38.79	19. 3944k	-88,664	
65.94	18. 8689k	-88,653	
73.55	18. 3956k	-68.644	
91.63	17.9173x	-88.634	
10.20	17.4492x	-68.619	
29.27	16. 9939k	-68,606	
48.84	16.5517k	-68, 588	
68.95	16, 1239k	-88. 574	
189, Se	15. 7055k	-88.570	-
10.79	15. 2958k	-88,564	

• General specifications of the IM3533-01

	Basic measure- ment items	Z,Y, θ ,Rs,R	p,X,G,B,Ls,Lp,Cs,Cp,Q,D	
Measure-	DCR	✓ (with temper	rature compensation function)	
ment items	Transformer measurement		N,M,⊿L	
	Temperature T	1		
Basic	c accuracy		±0.05%rdg.	
Measurer	Measurement frequency		mHz to 200kHz	
Measurement voltage		5mV to 5V/2.5V ^{*1}		
Measurement time		2ms		
Comparator		2 item	s: HI/IN/LO, ABS/%/Δ%	
BIN measurement		2 item	ns: 10 classifications	
Cab	Cable length		0m/1m/2m/4m	
Cont	Contact check		4-terminal contact check (threshold change) / Hi-Z reject	
Internal DC b	Internal DC bias measurement		-5V to 5V	
Sweep measurement		Frequency 2 to 801 points		
Display		Color TFT 5.7-inch LCD touch screen		
	EXT I/O,		✓	
Interface	USB flas	h drive	✓	
	RS-232C, G	P-IB, LAN	Option (select one)	
		h drive	✓ ✓ Option (select one)	

^{*1} 2.5 V in the low impedance high accuracy mode

Cable length setting to 0m/1m and 2m/4m with guaranteed accuracy

(IM3533-01)

The cable length can be set to 0m/1m (common for the series) and to 2m/4m for the IM3533-01. Even when the measurement cable needs to be extended in laboratories and for automated machinery, the maximum performance can be ensured and the maximum accuracy can be guaranteed. When using an extension cable, be sure to refer to the instruction manual.

Functions and Features for LCR Measurements in Research and Development

IM3533 IM3533-01

Measurable from low frequencies from 1 mHz

(frequency sweep)

Measurements can be performed from low frequencies from 1 mHz at 1 mHz resolution^{*2}. The function can be used for the basic measurements of electrochemical applications.

*2 Five-digit resolution at 100 Hz or more.

Advantage #2

Low impedance high accuracy mode improves repeat accuracy

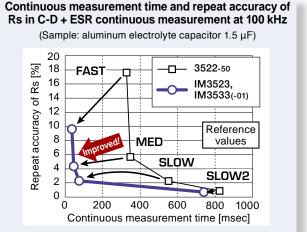
The IM3523 and IM3533(-01) provide a low impedance high accuracy mode that improves repeat accuracy in low-impedance measurements.

Compared to the previous HIOKI model 3522-50, the measurement speed of C-D + ESR continuous measurement in FAST and MED modes has increased by one digit and the repeat accuracy (variation) of Rs has also been improved.

• Low impedance high accuracy mode

Low impedance high accuracy mode can be used at 100 m Ω and in the 1 Ω range. Output resistance of 25 Ω can increase the measured current and thus improve the measurement accuracy. (The maximum applied current is 100 mA and the maximum applied voltage is 2.5 V)

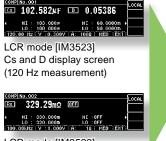
This mode is useful during L measurement of low-inductance inductors for power supplies and ESR measurement of aluminum electrolytic capacitors.



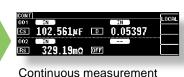
Capacitors and Inductors

C-D + ESR Measurement of Capacitors

IM3523 IM3533 IM3533-01



LCR mode [IM3523] Rs display screen (100 kHz measurement)



screen [IM3523]

Continuous measurement can be performed with high speed under multiple conditions!

C-D (120 Hz) and low ESR (100 Hz) measurement can be performed for functional polymer capacitors. Different measurement items can be measured continuously under different measurement conditions (frequency, level, and mode).

C Measurement of Polar Capacitors

Image: state state



Enlarged view of bias set

LCR mode When DC bias is set A DC bias voltage may sometimes be applied to measure polar capacitors such as an electrolytic capacitor.

The IM3533(-01) can perform C-D measurement by applying a DC bias voltage of -5V to 5V without using an optional DC bias unit.

DCR and L-Q Measurement of Inductors (Coils and Transformers)



L and Q display screen (1 kHz, 1 mA constant current measurement)



Rdc display screen (DC measurement)

Advantage #3



L, Q and Rdc continuous measurement screen

L and Q (1 kHz, 1 mA constant current measurement) and Rdc (DC measurement) display screen L-Q (1 kHz, 1 mA constant current) and DCR can be measured continuously and the measurement results can be displayed on the same screen.

IM3533

IM3533-01

IM3523

Measurement with a constant current (CC) can be performed for current dependent elements such as coils incorporating cores, the inductance value of which varies depending on the applied current.

With the IM3533(-01), repeat accuracy during low impedance measurements has been improved from previous HIOKI models to ensure stable measurement of DCR.



DCR measurement with temperature compensation*

The IM3533-01 provides DCR measurement with temperature compensation, which makes it possible to manage winding resistance more accurately.

The low impedance high accuracy mode allows you to measure low-inductance inductors and low-DCR inductors more accurately than previous HIOKI models.

* Temperature Probe 9478 (option) is required for DCR measurement with temperature compensation.

IM3533 (IM3533-01

Transformer Winding and Sweep Measurements

Variety of Transformer Winding Measurement Functions

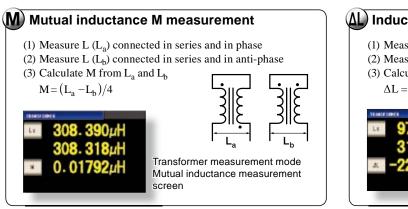
IM3533 IM3533-01

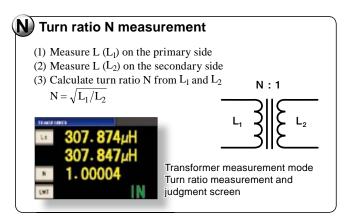
In addition to the L-Q and DCR measurements, the IM3533 and IM3533-01 enable you to measure the turn ratio N, mutual inductance M, and inductance difference ΔL that are required for the measurement of transformers.^{*}

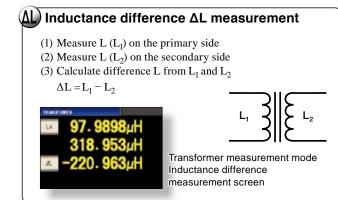
 * Connections must be switched manually or a selector such as a scanner unit is required separately.



Transformer measurement mode Turn ratio measurement (information) screen





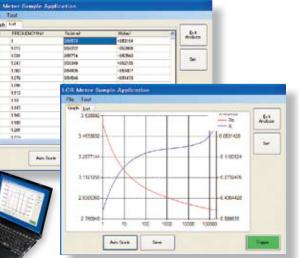


Sweep Measurement

The IM3533-01 provides a frequency sweep measurement function that allows you to measure the inductance (L), capacitance (C), and frequency characteristics of samples such as composite components. The function is useful in research and development.

The bundled LCR sample application can be used to display a frequency characteristic list and graph on a computer screen.





Sweep measurement results list and graph screens as shown in the bundled LCR sample application

Linking to PC Capturing Measurement Data

Saving and loading data via front USB port

Measurement results and settings can be saved to a commercially available USB flash drive connected to the front USB port.

(The USB port on the front panel is specifically for a USB flash drive. Batch save all the measurement results to a USB flash drive after saving them to the internal memory of the IM3533(-01). Some USB flash drives may not be supported due to incompatibility issues.)



Measurement results and settings

IM3533 IM3533-01



EXT I/O (handler interface) EXT I/O RS-232C/LAN/GP-IB (handler interface) option USB USB (for connecting to a PC) Temperature sensor connection connector IM3533(-01) rear panel

 Connecting to a PC via USB

IM3523 IM3533 IM3533-01

IM3523

IM3533

IM3533-01

The rear panel is standard equipped with a USB port.

(The USB port on the rear panel is specifically for connecting to a PC.)

Control the various functions of the IM3523 and IM3533(-01) from a PC and download measurement results.

(Excluding turning the power on/off and configuring some interface settings.)

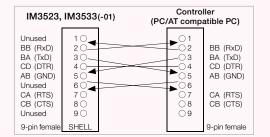
USB connection PC

Connecting to a PC or PLC via RS-232C, LAN, or GP-IB (select one option) connection

When you need an RS-232C, LAN, or GP-IB interface, you can select any one option.

Control the various functions of the IM3523 and IM3533(-01) from a PC and download measurement results. (Excluding turning the power on/ off and configuring some interface settings.)

Use an appropriate RS-232C cable in accordance with the connection method shown in the figure below. A crossover cable for interconnection can be used.



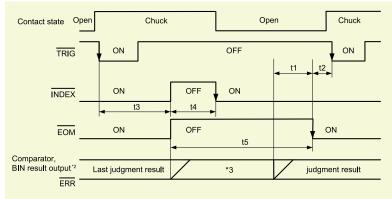


EXT I/O

Handler (EXT I/O) interface

The handler (EXT I/O) interface enables output of an end of measurement signal and measurement result signal, and input of signals such as a measurement trigger signal to control the measuring instrument. Each of the signal lines is isolated from the measurement and control circuits, and the structure is designed to protect against noise.

Example of Typical EXT I/O Timing (LCR Mode)



Approximate measurement speed

(at 1 kHz and wh	en the screen	display is	OFF *4)

(
FAST MED		SLOW	SLOW2		
2ms	6ms	21ms	301ms		

EXT I/O signal list

Input signals

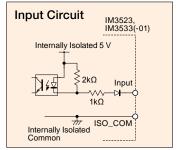
· · · · · · ·			
TRIG		External trigger	
LD0 to LD6		Panel number selection	
LD_VALID		Panel load execution	
● Output signals			

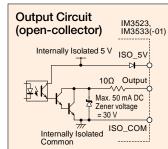
EOM	End of measurement
	End of capture
ERR	Measurement error output
ISO_5V	Internally isolated 5 V
ISO_COM	Internally isolated common

Output signals (common signal line)

IM3523	IM3533, IM3533-01	
MAIN-HI, MAIN-IN, MAIN-LO, SUB-HI, SUB-IN, SUB-LO, AND, SUBNG	PARAx-HI, PARAx-IN, PARAx-LO (x=1,3), AND	Comparator judgment result output
$\overline{\text{BINx}}$ (x=1 to 10), $\overline{\text{OUT}}$	BINX (x=1 to 10), OUT_OF_BINS	BIN judgment result output
No.n_x-HI, No.n_x-IN, No.n_x-LO (n=1,2; x=MAIN, SUB)	No.n_PARAx-HI, No.n_PARAx-IN, No.n_PARAx-LO (n=1,2; x=1,3)	Continuous measure- ment result output
	HI, IN, LO, AND	Transformer mode

EXT I/O Input and Output Circuits





When designing a control system using the EXT I/O interface, be sure to read the instruction manual and check the necessary technical information.

- t1: Delay setting time from comparator and BIN judgment results to EOM (LOW): 40 µs or longer *1
- t2: Minimum time from end of measurement to next trigger: 400 µs *1
- t3: Time from trigger to response by circuit: 700 µs *1 t4: Minimum chuck time for which the chuck can be switched with
- INDEX (LOW): 220 µs *1
- t5: Measurement time: 600 µs *1
- *1: When the measurement speed is FAST and the range is HOLD.
- *2:IM3523: MAIN-HI, MAIN-IN, MAIN-LO, SUB-HI, SUB-IN, SUB-LO, AND, BINX, OUT-OF-BINS, SUBNG IM3533(-01): PARAX-HI, PARAX-IN, PARAX-LO, AND, BINX, OUT_OF_BINS
- *3:Reset at the same time as TRIG: HIGH Not reset at the same time as TRIG: LOW
- *4: Add up all the applicable times in the following cases. • When OPEN/SHORT/LOAD compensation is executed: max 0.4 ms
 - When comparator measurement is executed: max 0.4 ms
 - When BIN measurement is executed: max 0.8 ms
 - When the screen display is ON: max 0.3 ms
 - When the memory function is ON: max 0.4 ms

EXT I/O Electrical Specifications

Inputs:

Photocoupler isolation: Non-voltage contact inputs (support for current sink output, negative logic) Assert: 0 to 1 V (with 3 mA input) De-assert: Open, or 5 to 30 V

Outputs:

Photocoupler isolation: Open-collector NPN (support for current sink output, negative logic) Max. 30 V and 50 mA per ch. Residual voltage: Max. 1.5 V @50 mA, or 1 V @10 mA.

Accessory Power Out (internally powered): 4.5 to 5 V DC @ 100 mA max.

Isolated from protective ground and measurement circuitry

Connectors

Connectors to use (unit side)	: 37-pin D-SUB female connector with #4-40 inch screws
Compliant	: DC-37P-ULR (solder type) and
connectors	DCSP-JB37PR (insulation-dis-
	placement type)
	For information on where to
	obtain connectors, consult your
	nearest HIOKI distributor.

IM3523, IM3533 and IM3533-01 Measurement Accuracy

Conditions

Temperature and humidity ranges: $23^{\circ}C \pm 5^{\circ}C$, 80% RH or less (no condensation), at least 60 minutes after power is turned on, after performing open and short compensation

Measurement accuracy

The measurement accuracy is calculated based on the following equation. Measurement accuracy = Basic accuracy × C × D × E × F × G

[C: Level coefficient]

V: Setting value (corresponds to V mode or equivalent) [V]

Excluding DCR	DCR
0.005V to 0.999V: 1+0.2/V	
1V: 1	2V: 1
1.001V to 5V: 1+2/V	

[D: Measurement speed coefficient]

Excluding DCR	DCR
FAST: 4	FAST: 8
MED: 3	MED: 4
SLOW: 2	SLOW: 2
SLOW2: 1	SLOW2: 1

[F: DC bias coefficient]

DC bias setting OFF: 1 DC bias setting ON: 2

Basic accuracy (Z, θ) calculation expressions

The basic accuracy is calculated by selecting coefficients A and B from the basic accuracy table and using the calculation expressions below.

1 kΩ range and above: Accuracy = $A + B \times \left \frac{10 \times Zx}{Range} \right -1$	In the 1 kΩ and below, t accuracy dif For details, examples or
100 Ω range and below:	1
Accuracy = $A + B \times \left \frac{Range}{Zx} - 1 \right $	Zx is the a value (Z) of

In the 1 k Ω range and above and 310 Ω range and below, the calculation expression of basic accuracy differs as shown in the left. For details, refer to the following calculation examples on page 13.

Zx is the actual impedance measurement value (Z) of the sample.

[E: Measurement cable length coefficient]

Cable law eth	IM3523	IM3533-01	
Cable length	$10k\Omega$ range and below	100k Ω range and above	11/13533-01
0m	1	1	1
1m	1.2	1.2	1.2
2m	1.5 + fm/100	1.5 + fm/20	1.5
4m	2 + fm/50	2 + fm/10	2

Please use a coaxial cable with 50Ω impedance characteristics and 4-terminal pair configuration.

Guaranteed accuracy range (frequency)

Cable law eth	IM3523	IM3533-01		
Cable length	10k Ω range and below	100k Ω range and above	11013533-01	
0m		Up to 200 kHz	Up to 200	
1m	Up to 200 kHz	UP 10 200 KHZ	kHz	
2m		Up to 100 kHz		
4m]	Up to 10 kHz	(No limit)	

[G: Temperature coefficient] t: Operating temperature

When t is 18°C to 28°C: 1

When t is 0°C to 18°C or 28°C to 40°C: 1+0.1× | t-23 |

When temperature compensation is performed during DCR measurement, add the following value to the calculation expression of basic accuracy.

$$\frac{-100 \ \alpha_{to} \Delta t}{1 + \alpha_{to} \times (t + \Delta t - t_0)} \ [\%]$$

t₀: Reference temperature [°C]

t: Current ambient temperature [°C]

- Δt: Temperature measurement accuracy
- a_{t_0} : Temperature coefficient for $t_0 [1/^{\circ}C]$

Basic accuracy table

Coefficients A and B

DC A is the accuracy of R (± % rdg.) B is the coefficient for the resistance of the sample			0.001Hz (40 Hz) to 200 Top A: Basic accuracy of Z B is the coefficient for	Bottom A: Ba	0.001 Hz (40 Hz) to 200 kHz Bottom A: Basic accuracy of θ (± % deg.) B is the coefficient for the impedance of the sample		
Range	Guaranteed accuracy range	DC	имз523 40.000Hz to 99.9999Hz имз533 (мз533о) 0.001Hz to 99.9999Hz	100.00Hz to 999.99Hz	1.0000kHz to 10.000kHz	10.001kHz to 100.00kHz	100.01kHz to 200.00kHz
100MΩ	8MΩ to 200MΩ	A=1 B=1	A=6 B=5 A=5 B=3	A=3 B=2 A=2 B=2	A=3 B=2 A=2 B=2		
10MΩ	800k Ω to 100M Ω	A=0.5 B=0.3	A=0.8 B=1 A=0.8 B=0.5	A=0.5 B=0.3 A=0.4 B=0.2	A=0.5 B=0.3 A=0.4 B=0.2	A=3 B=2 A=2 B=2	
1MΩ	80kΩ to 10MΩ	A=0.2 B=0.1	A=0.4 B=0.08 A=0.3 B=0.08	A=0.3 B=0.05 A=0.2 B=0.02	A=0.3 B=0.05 A=0.2 B=0.02	A=0.7 B=0.08 A=1.3 B=0.08	A=1 B=0.5 A=3 B=0.5
100kΩ	8kΩ to 1MΩ	A=0.1 B=0.01	A=0.3 B=0.03 A=0.3 B=0.02	A=0.2 B=0.03 A=0.1 B=0.02	A=0.15 B=0.02 A=0.1 B=0.015	A=0.25 B=0.04 A=0.4 B=0.02	A=0.4 B=0.3 A=1.2 B=0.3
10kΩ	800Ω to 100kΩ	A=0.1 B=0.01	A=0.3 B=0.025 A=0.3 B=0.02	A=0.2 B=0.025 A=0.1 B=0.02	A=0.05 B=0.02 A=0.03 B=0.02	A=0.2 B=0.025 A=0.4 B=0.02	A=0.3 B=0.03 A=0.6 B=0.05
1kΩ	80Ω to 10kΩ	A=0.1 B=0.01	A=0.3 B=0.02 A=0.2 B=0.02	A=0.2 B=0.02 A=0.1 B=0.02	A=0.15 B=0.02 A=0.08 B=0.02	A=0.2 B=0.02 A=0.4 B=0.02	A=0.3 B=0.02 A=0.6 B=0.02
100Ω	8Ω to 100Ω	A=0.1 B=0.02	A=0.4 B=0.02 A=0.2 B=0.01	A=0.3 B=0.02 A=0.15 B=0.01	A=0.15 B=0.02 A=0.1 B=0.01	A=0.2 B=0.02 A=0.4 B=0.02	A=0.3 B=0.03 A=0.6 B=0.02
10Ω	800mΩ to 10Ω	A=0.2 B=0.15	A=0.5 B=0.2 A=0.3 B=0.1	A=0.4 B=0.05 A=0.3 B=0.03	A=0.3 B=0.05 A=0.15 B=0.03	A=0.3 B=0.05 A=0.75 B=0.05	A=0.4 B=0.2 A=1.5 B=0.1
1Ω	80m Ω to 1 Ω	A=0.3 B=0.3	A=2 B=1 A=1 B=0.6	A=0.6 B=0.3 A=0.5 B=0.2	A=0.4 B=0.3 A=0.25 B=0.2	A=0.4 B=0.3 A=1 B=0.2	A=1 B=1 A=2 B=0.5
100mΩ	10m Ω to 100m Ω	A=3 B=3	A=10 B=10 A=6 B=6	A=3 B=3 A=2 B=2	A=3 B=2 A=2 B=1.5	A=2 B=2 A=2 B=1.5	A=4 B=3 A=3 B=4

Measurement Accuracy

Guaranteed accuracy range (measurement signal level)

The guaranteed accuracy range varies depending on the measurement frequency, measurement signal level, and measurement range.

Range	DC	IM3523 40.000Hz to 99.9999Hz IM3533 IM353301 0.001Hz to 99.9999Hz	100.00Hz to 999.99Hz	1.0000kHz to 10.000kHz	10.001kHz to 100.00kHz	100.01kHz to 200.00kHz
100MΩ						
10MΩ		0.101 V to 5 V 0.050 V to 5 V			0.501 V to 5 V	
1MΩ				0.101 V to 5 V	0.501 V 10 5 V	
100kΩ	2 V	0.005 \		(to E)/	0.050 V to 5 V	0.101 V to 5 V
10kΩ, 1kΩ, 100Ω	2 V	0.005 V to 5 V				
10Ω		0.050 V to 5 V				
1Ω		0.101 V to 5 V (When DC bias: 1 V to 5 V)				
100mΩ		0.501 V to 5 V (When DC bias: 0.501 V to 5 V)				

The above voltages are the voltage setting values corresponding to V mode or equivalent.

For the 10 M Ω to 1 k Ω range, when the measurement impedance value exceeds the range, the guaranteed accuracy range is as follows.

Range	DC	(M3523) 40.000Hz to 99.9999Hz	100.00Hz to	1.0000kHz to	10.001kHz to	100.01kHz to	
Trange De		M3533 (M3533-01) 0.001Hz to 99.9999Hz	999.99Hz	10.000kHz	100.00kHz	200.00kHz	
10MΩ		0.101 V to 5 V					
1MΩ							
100kΩ	2 V	0.050 V to 5 V		0.101 V to 5 V	0.501 V to 5 V		
10kΩ		0.005 V to 5 V		(to E)/	0.005 V to 5 V 0.101 V to 5 V		
1kΩ		0.005 V 10 5 V					

The above voltages are the voltage setting values corresponding to V mode or equivalent.

Method for determining basic accuracy

• Calculate the basic accuracy from the sample impedance, measurement range, measurement frequency, and corresponding basic accuracy A and coefficient B from the table on page 12.

- \bullet The calculation expression to use differs for each of the 1 k Ω range and above and 100 Ω range and below.
- For C and L, obtain basic accuracy A and coefficient B by determining the measurement range from the actual measurement value of impedance or the approximate impedance value calculated with the following expression.

$$Zx(\Omega) \approx \omega L(H) \quad (\theta \approx 90^{\circ})$$

$$\approx \frac{1}{\omega C(F)} (\theta \approx -90^{\circ})$$

R (Ω) $(\theta \approx 0^{\circ})$ (ω : 2 x π x Measurement frequency [Hz])

Calculation example 1 (Basic accuracy of impedance Z)

Impedance Zx of sample: 500 Ω (actual measurement value) Measurement conditions: When frequency 10 kHz and range 1 k Ω

Basic accuracy can be calculated on a PC

The bundled application software can be used to calculate the basic accuracy. Just enter the measurement conditions and measurement result and the measurement accuracy will be displayed.

measurement value.

Z

The application software allows you to easily evaluate the accuracy for the · ··· ··· ··· Application screen

Insert coefficient A = 0.15 and coefficient B = 0.02 for the Z basic accuracy from the table on page 12. .

basic accuracy =
$$0.15 + 0.02 \times \left| \frac{10 \times 500}{10^3} - 1 \right| = 0.23 (\pm \% \text{ rdg.})$$

Similarly, insert coefficient A = 0.08 and coefficient B = 0.02 for the θ basic accuracy, as follows: 10 500 1

$$\theta$$
 basic accuracy = $0.08 + 0.02 \times \left| \frac{10 \times 500}{10^3} - 1 \right| = 0.16 (\pm^{\circ})$

Calculation example 2 (Basic accuracy of capacitor Cs = 160 nF)

(1) Measure Z and θ of the sample with measurement range AUTO.

(2) Suppose you have obtained the following Z and θ measurement values. $Z = 1.0144 \text{ k}\Omega, \quad \theta = -78.69 \text{ c}$

As Z is 1.0144 k Ω , the range is 10 k Ω .

(3) For the 1 kHz and 10 k Ω range,

insert coefficient A = 0.05 and coefficient B = 0.02 for the Z basic accuracy from the table on page 12. 1 10 10144 103

Z basic accuracy =
$$\pm \left(0.05 + 0.02 \times \left| \frac{10 \times 1.0144 \times 10^{9}}{10 \times 10^{3}} - 1 \right| \right) \approx 0.05 (\pm \%)$$

Insert coefficient A = 0.03 and coefficient B = 0.02 for the θ basic accuracy.

 $10 \times 1.0144 \times 10^{3}$ -1) $\approx 0.03 (\pm^{\circ})$ θ basic accuracy = $\pm (0.03 + 0.02 \times$ 10×103

(4) Determine the ranges for the Z and θ basic accuracy.

- Zmin = 1.0144 k $\Omega \times (1 0.05/100) = 1.01389$ k Ω
- Zmax = $1.0144 \text{ k}\Omega \times (1 + 0.05/100) = 1.01490 \text{ k}\Omega$
- $\theta \min = -78.69 0.03 = -78.72$ °
- θ max = -78.69 + 0.03 = -78.66 °
- (5) Determine the range for Cs from the Z and θ ranges.

Cs min = $1 / (Zmax \times \omega \times sin(\theta min)) \approx 159.907 \text{ nF} \dots -0.06\%$

Cs max = $1 / (Zmin \times \omega \times sin(\theta max)) \approx 160.100 \text{ nF} \dots +0.06\%$

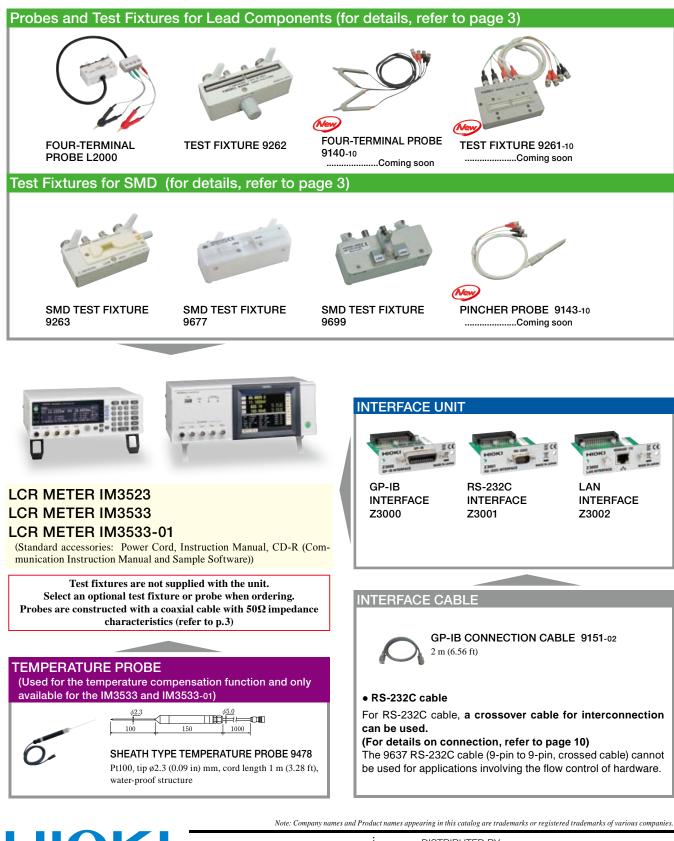
Specifications

	IM3523	IM3533	IM3533-01			
Measurement modes	LCR mode: Measurement with single condition Continuous measurement mode: Continuous measurement under saved conditions (maximum 2 sets)	LCR mode: Measurement with single condition Transformer measurement mode: N, Μ, ΔL Continuous measurement mode: Continuous measurement under saved conditions LCR mode (maximum 60 sets)	LCR mode: Measurement with single condition Transformer measurement mode: N, M, ΔL Continuous measurement mode: Continuous measurement under saved conditions LCR mode (maximum 60 sets) Analyzer mode (maximum 2 sets) Analyzer mode: Sweep with measurement frequency (Measurement points: 2 to 801 Sweep method: normal sweep Display: List display)			
Measurement parameters	Z, Y, θ, Rs(ESR), Rp, DCR(DC resistance), X, G, B, Cs, Cp, Ls, Lp, D(tanδ), Q	Z, Y, θ , Rs(ESR), Rp, DCR(DC resistan N, M, Δ L, T	ce), X, G, B, Cs, Cp, Ls, Lp, D(tan\delta), Q,			
Measurement range	100 mΩ to 100	MΩ, 10 ranges (All parameters are determined	according to Z)			
Display range		, Cp : \pm (0.000000 [unit] to 9.999999G [unit]) A to 9.999999), Q : \pm (0.00 to 99999.9), Δ % : \pm (
Basic accuracy		$Z : \pm 0.05\%$ rdg. $\theta : \pm 0.03^{\circ}$				
Measurement frequency	40 Hz to 200 kHz (1 mHz to 10 Hz steps)	1 mHz to 200 kHz (1	mHz to 10 Hz steps)			
Measurement signal level	Normal mode: V mode/CV mode: 5 mV to 5 Vrms, 1 mVrms steps CC mode: 10 µA to 50 mArms, 10 µArms steps	Normal mode: V mode/CV mode: 5 mV to 5 Vrms, 1 mVrms steps CC mode: 10 μA to 50 mArms, 10 μArms steps Low impedance high accuracy mode: V mode/CV mode: 5 mV to 2.5 Vrms, 1 mVrms steps CC mode: 10 μA to 100 mArms, 10 μArms steps				
Output impedance	Normal mode: 100 Ω	Normal mode: 100 Ω , Low impedance high accuracy mode: 25 Ω				
Display	Monochrome LCD	5.7-inch color TFT, display can be set to ON/OFF				
Number of display digits setting	The number	of display digits can be set from 3 to 6 (initial va	alue: 6 digits)			
Measurement time	2 ms (1 kHz, FAST, display OFF, representative value)					
Measurement speed		FAST/MED/SLOW/SLOW2				
DC bias measurement		Normal mode: -5.00 V to 5.00 V (10 mV steps) Low impedance high accuracy mode: -2.50 V to 2.50 V (10 mV steps)				
DC resistance measurement	Measurement signal level: Fixed to 2 V	Measurement signal level: Fixed to 2 V Temperature compensation function: Converted reference temperature is displayed Reference temperature setting range: -10°C to 99.9°C Temperature coefficient setting range: -99.999ppm/°C to 99.999ppm/°C				
Comparator		LCR mode: Hi/IN/Lo for first and third items				
BIN measurement	10 main parameter categories, 1 sub-parameter category, and out of range		t of range for 2 items			
Compensation	Open/short/load/correlation com Cable length: 0 and 1 m (accuracy		Open/short/load/correlation compensation Cable length: 0, 1, 2, 4 m			
Residual charge protection function	$V = \sqrt{10}/$	\overline{C} (C: Capacitance [F] of test sample, V = ma	x. 400 V)			
Trigger synchronous output function	Applies	a measurement signal during analog measurem	ent only			
Averaging		1 to 256				
Panel loading/saving	LCR n	node: 60; Analyzer mode: 2; Compensation value	ue: 128			
Memory function	Store	es 32,000 data items to the memory of the instru	ment			
Interfaces	EXT I/O (handler), USB (Hi-Speed) Option: Any one of RS-232C, GP-IB, and LAN (10BASE-T/100BASE-TX) can be selected					
Operating temperature and humidity ranges	0 °C (32 °F) to 40 °C (104 °F) , 80% rh or less, no condensation					
Storage temperature and humidity ranges	-10°C (14°F) to 50 °C (122°F), 80% rh or less, no condensation					
Power supply	AC 100 to 240 V, 50/60 Hz, 50 VA max.					
Dimensions and weight	Approx. 260 mm (10.24 in) W × 88 mm (3.46 in) H ×203 mm (7.99 in) D, approx. 2.4 kg (84.7 oz)	Approx. 330 mm (12.99 in) W × 119 mm (4.69 in) H × 168 mm (6.61 in) D, approx. 3.1 kg (109.3 oz)				
Accessories	Power Cord ×1, Instruction Manual ×1, CD-R (Communication Instruction Manual and Sample Software) ×1					
Applicable standards	EMC: EN61326-1, EN61000-3-2, EN61000-3-3, Safety standard: EN61010					

LCR Meter Series Full Product Lineup Measurement speed Measurement frequency range (Basic value) Model Applications and measurement object DC 1mHz 200kHz 2ms ()LCR METER IM3533-01 High-end model of the IM3523 and IM3533 with sweep measurement For electrochemistry applications, research and development and production lines of electronic components 200kHz DC 1mHz 2ms ()LCR METER IM3533 Capable of special measurements of transformers including turn ratio and mutual inductance Particularly useful in production lines and research and development of transformers, coils, etc. DC 40Hz 200kHz 2ms Ο LCR METER IM3523 Extremely cost-effective model suitable for production lines including integration into automated machinery For C-D and ESR measurement of electrolytic capacitors and L-Q and DCR measurement of inductors 100kHz 120MHz 6ms LCR HITESTER 3535 High-frequency measurement at 120 MHz Ideal for production lines of ferrite beads and inductors DC 4Hz 5MHz 0.5ms IMPEDANCE ()ANALYZER IM3570 LCR meter integrated with impedance analyzer Measure the frequency characteristics of piezo-electric devices, functional polymer capacitors, and power inductors 42Hz 5MHz 5ms LCR HITESTER 3532-50 General-purpose LCR meter at 5 MHz Measure electronic components such as capacitors and inductors 120Hz 1kHz 5ms \bigcirc LCR HITESTER 3511-50 Compact LCR meter with single function For production lines of aluminum electrolytic capacitors 1kHz 100kHz 1MHz 3505 2ms **C HITESTER** 3506 3505/3506 C meter for low-capacity capacitors For production of MLCC and film capacitors 120Hz 1kHz 2ms **C HITESTER** 3504-40/50/60 C meter for large-capacity MLCCs For sorting machines of large-capacity MLCCs (3504-50/60)

and taping machines (3504-40)

Options



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